

Search Notes**Application/Control No.**

10/825,531

Examiner

Leigh C. Maier

Applicant(s)/Patent under Reexamination

SHINKAI ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
558	240-243 246 250 254-258	6/29/2006	LCM
564	84 154	6/29/2006	LCM
564	166	6/29/2006	LCM
564	188-191	6/29/2006	LCM
search	updated	12/22/2006	LCM
564	123	12/22/2006	LCM
514	613	12/22/2006	LCM
search	updated	3/13/2008 ¹	LCM
search	updated	LCM	
for			
514	613	6/15/2006	LCM
558	257	6/15/2007	LCM
564	191	6/15/2007	LCM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-STN structure search	6/29/2006	LCM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
514	613	6/15/2007	LCM
558	257	6/15/2007	LCM
564	191	6/15/2007	LCM